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Form PTO-1449 US Dept. of Commerce (REV. 8-83) PATENT & TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT		ATTY DOCKET NO. 111778			APPLICATION NO. 10/052,255							
(Use several sheets if necessary)			APPLICANT(S) Akihiko EBINA et al.									
			FILING January		GROUP 2829							
U.S. PATENT DOCUMENTS												
EXAMINER INITIAL	DOCUMENT NUMBER	DATE		NAME		CLASS	SUB CLASS					
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SBG	JP 05-326976 (w/Abstract)	10/1993		Japan								
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EXAMINER DATE CONSIDERED 1/19 0												
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in												
conformance and not considered. Include copy of this form with next communication to applicant.												

Date: July 29, 2003